P54/74FCT540T/AT/CT-P54/74FCT541T/AT/CT OCTAL BUFFERS/LINE DRIVERS WITH 3-STATE OUTPUTS

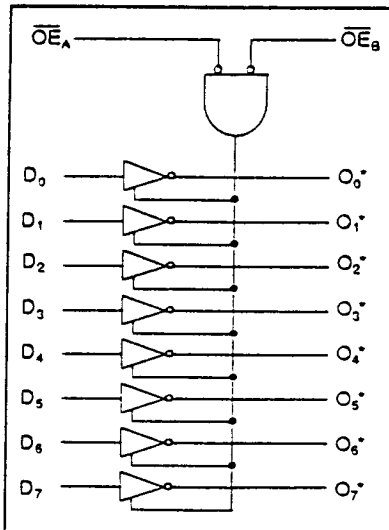
FEATURES

- Function, Pinout and Drive Compatible with the FCT and F Logic
- FCT-C speed at 4.3ns max. (Com'l)
  FCT-A speed at 4.8ns max. (Com'l)
- Reduced V_{OH} (typically = 3.3V) versions of Equivalent FCT functions
- Edge-rate Control Circuitry for Significantly Improved Noise Characteristics
- ESD protection exceeds 2000V
- Power-off disable feature
- Matched Rise and Fall times
- Fully Compatible with TTL Input and Output Logic Levels
- 64 mA Sink Current (Com'l), 32 mA (Mil)
  15 mA Source Current (Com'l), 12 mA (Mil)
- 3-State Outputs
- Manufactured in 0.7 micron PACE Technology™

DESCRIPTION

The 'FCT540T and the 'FCT541T are octal buffers and line drivers designed to be employed as memory address drivers, clock drivers and bus-oriented transmitters/receivers. The devices provide speed and drive capabilities equivalent to their fastest bipolar logic counterparts while reducing power dissipation. The input and output voltage levels allow direct interface with TTL, NMOS and CMOS devices without external components.

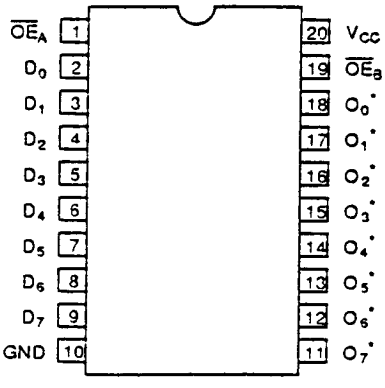
FUNCTIONAL BLOCK DIAGRAM



'FCT540T/541T

*$\overline{O}_n$ for 'FCT540T

PIN CONFIGURATIONS



DIP (D2,P2),
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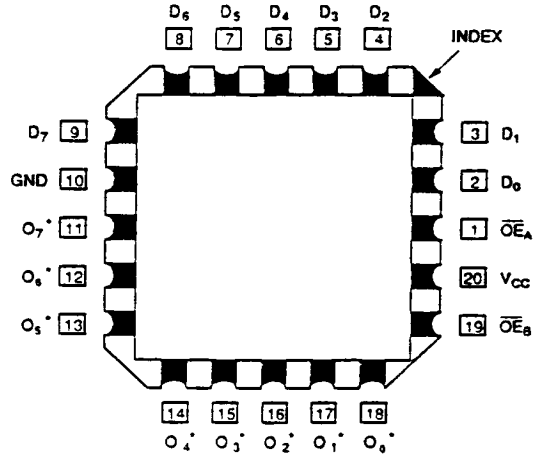

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PERFORMANCE SEMICONDUCTOR CORPORATION

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ABSOLUTE MAXIMUM RATINGS[1,2]

Symbol	Parameter	Value	Unit
T_{STG}	Storage Temperature	–65 to +150	°C
T_A	Ambient Temperature Under Bias	–65 to +135	°C
V_{CC}	V_{CC} Potential to Ground	–0.5 to +7.0	V
P_T	Power Dissipation	0.5	W

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Symbol	Parameter	Value	Unit
I_{OUTPUT}	Current Applied to Output	120	mA
V_{IN}	Input Voltage	–0.5 to +7.0	V
V_{OUT}	Voltage Applied to Output	–0.5 to +7.0	V

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Notes:

1. Operation beyond the limits set forth in the above table may impair the useful life of the device. Unless otherwise noted, these limits are over the operating free-air temperature range.
2. Unused inputs must always be connected to an appropriate logic voltage level, preferably either V_{CC} or ground.

RECOMMENDED OPERATING CONDITIONS

Free Air Ambient Temperature	Min	Max
Military	–55°C	+125°C
Commercial	0°C	+70°C

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Supply Voltage (V_{CC})	Min	Max
Military	+4.5V	+5.5V
Commercial	+4.75V	+5.25V

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DC ELECTRICAL CHARACTERISTICS (Over recommended operating conditions)

Symbol	Parameter		Min	Typ[1]	Max	Units	V_{CC}	Conditions
V_{IH}	Input HIGH Voltage		2.0			V		
V_{IL}	Input LOW Voltage				0.8	V		
V_H	Hysteresis			0.2		V		All inputs
V_{IK}	Input Clamp Diode Voltage			–0.7	–1.2	V	MIN	I_{IN} = –18mA
V_{OH}	Output HIGH Voltage	Military	2.4	3.3		V	MIN	I_{OH} = –12mA
		Commercial	2.4	3.3		V	MIN	I_{OH} = –15mA
V_{OL}	Output LOW Voltage	Military		0.3	0.55	V	MIN	I_{OL} = 32mA
		Commercial		0.3	0.55	V	MIN	I_{OL} = 48mA
		Commercial		0.3	0.55	V	MIN	I_{OL} = 64mA
I_I	Input HIGH Current				20	µA	MAX	V_{IN} = V_{CC}
I_{IH}	Input HIGH Current				5	µA	MAX	V_{IN} = 2.7V
I_{IL}	Input LOW Current				–5	µA	MAX	V_{IN} = 0.5V
I_{OZH}	Off State I_{OUT} HIGH-Level Output Current				10	µA	MAX	V_{OUT} = 2.7V
I_{OZL}	Off State I_{OUT} LOW-Level Output Current				–10	µA	MAX	V_{OUT} = 0.5V
I_{OS}	Output Short Circuit Current[2]		–60	–120	–225	mA	MAX	V_{OUT} = 0.0V
I_{OFF}	Power-off Disable				100	µA	0V	V_{OUT} = 4.5V
C_{IN}	Input Capacitance[3]			5	10	pF	MAX	All inputs
C_{OUT}	Output Capacitance[3]			9	12	pF	MAX	All outputs
I_{CC}	Quiescent Power Supply Current			0.2	1.5	mA	MAX	$V_{IN} \leq 0.2V$, $V_{IN} \geq V_{CC}-0.2V$

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Notes:

1. Typical limits are at V_{CC} = 5.0V, T_A = +25°C ambient.
2. Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high speed test apparatus and/or sample and hold techniques are preferable in order to minimize internal chip heating and more accurately reflect operational values. Otherwise prolonged shorting of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{os} tests should be performed last.
3. This parameter is guaranteed but not tested.

DC CHARACTERISTICS (Over recommended operating conditions unless otherwise specified.)

Symbol	Parameter	Typ[1]	Max	Units	Conditions
ΔI_{CC}	Quiescent Power Supply Current (TTL inputs)	0.5	2.0	mA	V_{CC} = MAX, V_{IN} = 3.4V[2], f_1 = 0, Outputs Open
I_{CCD}	Dynamic Power Supply Current[3]	0.15	0.25	mA/ mHz	V_{CC} = MAX, One Input Toggling, 50% Duty Cycle, Outputs Open, $\overline{OE}_A$ = $\overline{OE}_B$ = GND, or $\overline{OE}_A$ = GND, OE_B = V_{CC} $V_{IN} \le 0.2V$ or $V_{IN} \ge V_{CC} - 0.2V$
I_C	Total Power Supply Current[5]	1.7	4.0	mA	V_{CC} = MAX, 50% Duty Cycle, Outputs Open, One Bit Toggling at f_1 = 10MHz, $\overline{OE}_A$ = $\overline{OE}_B$ = GND, or $\overline{OE}_A$ = GND, OE_B = V_{CC} $V_{IN} \le 0.2V$ or $V_{IN} \ge V_{CC} - 0.2V$
		2.0	5.0	mA	V_{CC} = MAX, 50% Duty Cycle, Outputs Open, One Bit Toggling at f_1 = 10MHz, $\overline{OE}_A$ = $\overline{OE}_B$ = GND, or $\overline{OE}_A$ = GND, OE_B = V_{CC} V_{IN} = 3.4V or V_{IN} = GND
		3.2	6.5[4]	mA	V_{CC} = MAX, 50% Duty Cycle, Outputs Open, Eight Bits Toggling at f_1 = 2.5MHz, $\overline{OE}_A$ = $\overline{OE}_B$ = GND, or $\overline{OE}_A$ = GND, OE_B = V_{CC} $V_{IN} \le 0.2V$ or $V_{IN} \ge V_{CC} - 0.2V$
		5.2	14.5[4]	mA	V_{CC} = MAX, 50% Duty Cycle, Outputs Open, Eight Bits Toggling at f_1 = 2.5MHz, $\overline{OE}_A$ = $\overline{OE}_B$ = GND, or $\overline{OE}_A$ = GND, OE_B = V_{CC} V_{IN} = 3.4V or V_{IN} = GND

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Notes:

1. Typical values are at V_{CC} = 5.0V, +25°C ambient.
2. Per TTL driven input (V_{IN} = 3.4V); all other inputs at V_{CC} or GND.
3. This parameter is not directly testable, but is derived for use in Total Power Supply calculations.
4. Values for these conditions are examples of the I_{CC} formula. These limits are guaranteed but not tested.
5. $I_C = I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC}$
   $I_C = I_{CC} + \Delta I_{CC} D_H N_T + I_{CCD}(f_0/2 + f_1 N_1)$
   I_{CC} = Quiescent Current with CMOS input levels
   ΔI_{CC} = Power Supply Current for a TTL High Input (V_{IN} = 3.4V)
   D_H = Duty Cycle for TTL Inputs High
   N_T = Number of TTL Inputs at D_H
   I_{CCD} = Dynamic Current Caused by an Input Transition Pair (HLH or LHL)
   f_0 = Clock Frequency for Register Devices (Zero for Non-Register Devices)
   f_1 = Input Frequency
   N_1 = Number of Inputs at f_1
   All currents are in milliamps and all frequencies are in megahertz.

TRUTH TABLES

'FCT540T

Inputs			Output
$\overline{OE}_A$	$\overline{OE}_B$	D	
L	L	L	H
L	L	H	L
H	H	X	Z

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'FCT541T

Inputs			Output
$\overline{OE}_A$	OE_B	D	
L	L	L	L
L	L	H	H
H	H	X	Z

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H = HIGH Voltage Level, L = LOW Voltage Level, X = Don't Care, Z = High Impedance

AC CHARACTERISTICS

Symbol	Parameter	'FCT540T 'FCT541T				'FCT540AT 'FCT541AT				'FCT540CT 'FCT541CT				Units	Fig. No.
		MIL		COM'L		MIL		COM'L		MIL		COM'L			
		Min.[1]	Max.	Min.[1]	Max.	Min.[1]	Max.	Min.[1]	Max.	Min.[1]	Max.	Min.[1]	Max.		
t_{PLH} t_{PHL}	Propagation Delay Data to Output(540)	1.5	9.5	1.5	8.5	1.5	5.1	1.5	4.8	1.5	4.7	1.5	4.3	ns	1, 2
t_{PLH} t_{PHL}	Propagation Delay Data to Output(541)	1.5	9.0	1.5	8.0	1.5	5.1	1.5	4.8	1.5	4.6	1.5	4.1	ns	1, 2
t_{PZH} t_{PZL}	Output Enable Time	1.5	10.5	1.5	10.0	1.5	6.5	1.5	6.2	1.5	6.5	1.5	5.8	ns	1 7 8
t_{PHZ} t_{PLZ}	Output Disable Time	1.5	10.0	1.5	9.5	1.5	5.9	1.5	5.6	1.5	5.7	1.5	5.2	ns	

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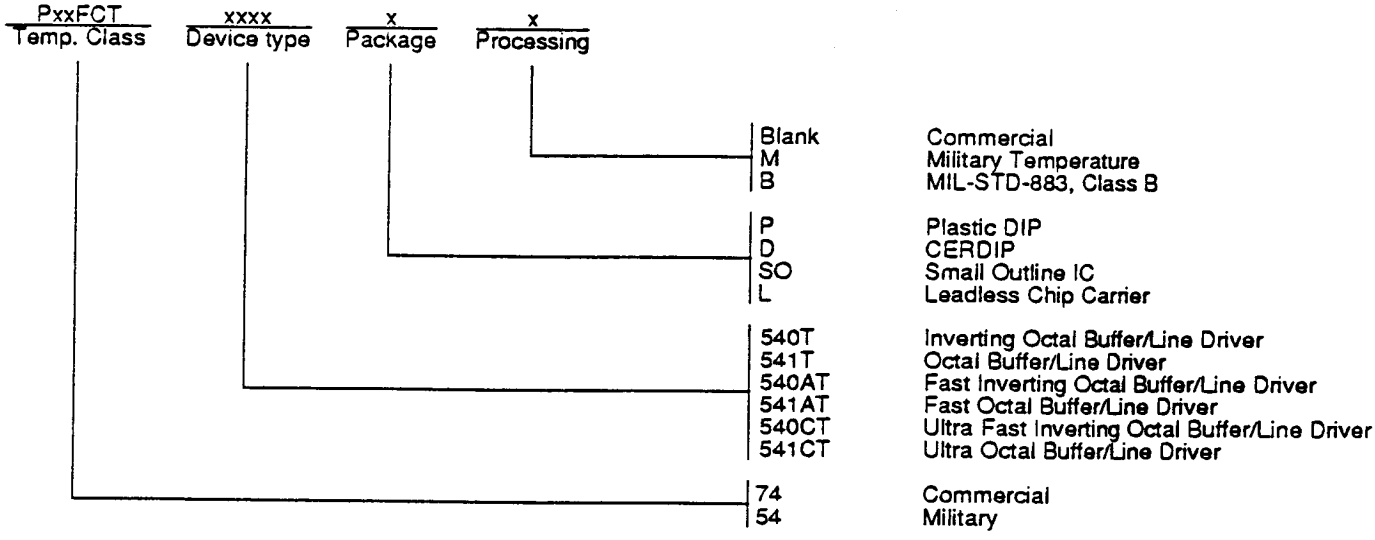
ORDERING INFORMATION



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